Mechanism of anodic oxide film formation on zircaloy-2, zircaloy-4, titanium and niobium (Radio tracer technique)

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ABSTRACT

The kinetics of anodic oxidation of zircaloy-2, zircaloy-4, titanium and niobium have been studied in 0.1M sodium methoxide without and with addition of a millimole of sodium phosphate at a constant current density of 8mA.cm-2 and at room temperature (300 K). the addition of phosphate ions found to improve the kinetics of film formation. This trend and mechanism of anodic oxide film growth is confirmed form radio – tracer technique using labeled phosphate ions. The conclusion of the results obtained is migration of anion impurity and accumulation of active phosphate in the layers of the oxide film formed.

Key words : Anodic oxide film, phosphate ions migration, mechanism, radio - tracer studies.

INTRODUCTION

Zakhalov *et at.* ¹ observed linear galvanostatic curves in the anodic oxidations of niobium over a broad range of current density values (0.1-10 mA.cm-2). They observed 100% current efficiency. During anodization they found different colors covering entire spectrum on the surface of the different formation voltages.

Bairachnyu and Gomozov² examined the effect of nature and composition of electrolyte on the properties of oxide films of niobium. They conducted anodic oxidation usinga potentiostat under galvanostatic conditions at currents of 30-100ma in 1-10% solutions of H_3PO_4 upto 100V. During oxidation in H_3PO_4 PH<0.8 (concentration ,10%), they found that $PO_4^{3^*}$ was introduced into the composition of the anodic oxide film. In this case, nonstoichiometric oxides of variable composition are formed including oxides of Nb and Phosphorous.

Young Observed that the Nb₂O₅ films are crystalline and the films recrystallize under the influence of applied field. Leach and panagopoulas 4 Studied the growth kinetics of anodization of zirconium in Na₃PO₄ and NaOH solutions. They showed that the anodization rate, current efficiency and electric field were found to be higher in the phosphate than in the hydroxide for the same growth current. This behavior was attributed to the incorporation of PO₄⁻³ into the growing oxide. Maraghini and Serra 5 Used radio – active phosphate and sulphate containing solutions to investigate the incorporation of these anions into the films formed by anodic oxidation.

Randall⁶ *et al.* Showed that the large amounts of phosphate were incorporated uniformly in the outer layer which decreased the permittivity and ionic conductivity of the oxide compared to films formed in dilute H_2SO_4 of comparable concentration. The two layer nature of anodic oxide film grown in H_3PO_4 was confirmed by Delloca and Young⁷. By

ellipsometric studies. Infrared transmission spectra of anodic films showed that anions such as phosphate, sulphate and carboxylate were incorporated⁸.

Raghunath Reddy 9 Confirmed the incorporation of phosphate into the anodic oxide films formed on niobium in 0.05M picric acid + 0.001M Na₃PO₄ having radio – active isotope ³²P. Anjaneyulu 10 Studied the mechanism of anodic film formation on Ti and Zr by using Na₂³⁵PO₄ and H¹⁴COONa. Shukla 11 Also confirmed the incorporation of phosphate into the anodic oxide films formed on Zr-4 and Nb in 0.1M sulphamic acid/Lithium hydroxide + 0.001M Na₃PO₄ having radio – active isotope ³²P.

In the present work, an attempt is made to study the mechanism of anodic oxide film formation on zircaloy-2, zircaloy-4, titanium and niobium in 0.1M sodium methoxide + 0.001M having radio – active isotope ${}^{32}P$ are studied.

MATERIAL AND METHODS

All the experiments were carried out using 0.2 mm thick, annealed, rolled sheet of zircaloy-2, zircaloy-4, titanium and niobium of more than 99.5% purity supplied by NFC, Hyderabad as a gift sample. The specimens used were cut with the aid of a punch giving working area of 1 cm2 on the either side and a tag of about 2 cm in length. Specimens were polished to mirror finish by using chemical polishing mixuture which consists of concentrated acids. HNO₃ HF and H₂SO₄ in the definite volume ratio.

Adams¹²⁻¹³ *et all* and Willis¹⁴ *et al.* used chemically polished specimens which give higher valules of current efficiency at higher current densities. A laboratory scale undivided cell was assembled with a 100 ml glass beaker, fitted with a PVC cover having slots to introduce. The anode and cathode. The platinum cathode had 20 cm² superficial area to make the double layer capacitance as large as possible. For radio – active experiments a specially designed cell of 20ml capacity in which a platinum cathode of "U" shape having 3 cm x 1 cm dimensions is arranged at the bottom of the cell. The specimens are suspended inside the "U" shape cathode. The thickness of anodic films formed was calculated from capacitance messurements. A digital LCR meter type VLCR-17 supplied by Vasavi Electronics (P) Ltd was used to measure the capacitance. The constant current generator used was supplied by Power tronics, Hyderabad.

An end window G.M. counter built by Nucleonix Pvt Ltd., Hyderabad with an automatic digital timer and counting system was used to measure the radio – active phosphate content of the film. Thinning experiments were also made using 0.5ì diamond paste to examine the depth distribution of phosphate ion impurties. All the reagents used were Analar grade and the solutions were prepared using double distilled water.

RESUTLS AND DISCUSSIONS

The chemically phlished ziraloy -2 zircaloy-4, titanium and niobium specimens were anodized separately in 0.1M sodium methoxide at a constant current density of 8mA.cm⁻² and at room temperature (300 K). the time taken for anodization and the capacitance of the film formed were measured at an interval of 20V by interrupting the constant current circuit. The plots of formation voltage vs. time reciprocal capacitance vs. time were found to be linear upto the breakdown voltage. The differential field across oxide and the current efficiency were calculated from these plots.

However a marked improvement in the kinetics of film formation with uniformity up to 240V is found with the addition of a millimole of Na_3PO_4 to 01M sodium methoxide.

The kinetic results, formation rate, current efficiency and differential field obtained for zircaloy-2, zircaloy-4, titanium and niobium are given in tables – 1,2,3,4. the improvement observed in the kinetics is attributed to the incorporation of anion impurities (PQ_4^{-3}) into the anodic film.

Radio – tracer studies mechanism

For the confirmation of incorporation of phosphate into the anodic oxide films formed on zircaloy-2, zircaloy-4, titanium and niobium in 0.1M sodium methoxide + 0.001M $Na_3^{32}PO_4$ an active solution of 8ml volume containing 2 drops of radio –

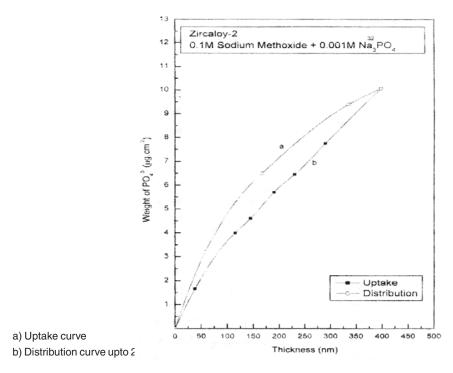


Fig. 1: Uptake and distribution of PO_4^{3} vs. thickness 0.1M sodium methoxide + 0.001M $Na_3^{32} PO_4$ (Zircaloy-2)

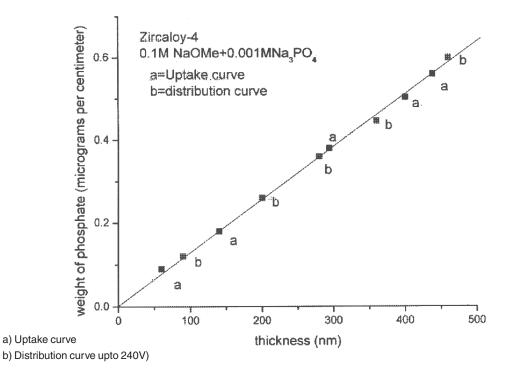


Fig. 2: Uptake and distribution of PO_4^{3} vs. thickness 0.1M sodium methoxide + 0.001M $Na_3^{32} PO_4$ (Zircaloy-4)

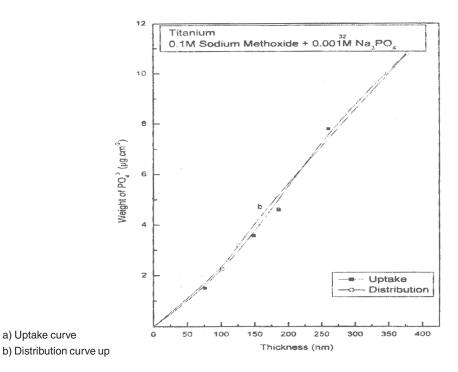


Fig. 3: Uptake and distribution of PO_4^{3-} vs. thickness 0.1M sodium methoxide + 0.001M Na_3^{32} PO_4 (Titanium)

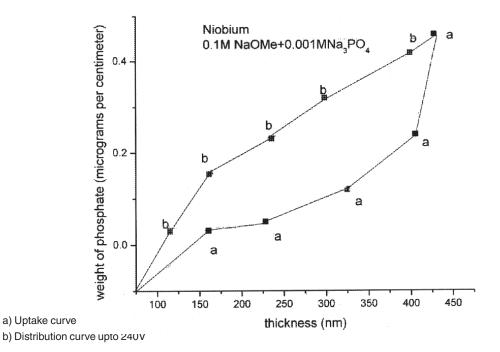


Fig. 4: Uptake and distribution of PO_4^{3-} vs. thickness 0.1M sodium methoxide + 0.001M $Na_3^{32} PO_4$ (Titanium)

active $Na_3^{32}PO_4$ was taken in the specially designed cell as described in the experimental part. Specific activity of the solution was 0.25μ Ci/mM.

Zircaloy – 2

From the counts measured at regular intervals of 40V the weight of the phosphate ion uptake was estimated and shown in the fig – 1 (curve a). the uptake is found to be uniform upto 240V. form the thining experiments using 0.5 μ . diamond paste the distribution curve isalso plotted and shown inth fig -1 (curve b). from the nature of the uptake and distribution curves the mechanism of anodic film formation on Zircaloy-2 in 0.1M sodium methoxide + 0.001M Na₃³²PO₄ is via

interstitial movement of oxygen ions through out the film the same mechanism of oxide film formation was given by Raghunath Reddy 15 for Zr-4 in 0.1M KOH+0.001M $Na_3^{32}PO_4$

Zircaloy-4, Titanium and Niobium

From the counts measured at regular intervals of 40V the weight of the phosphate ion uptake was estimated for zircaloy – 4 titanium and niobium and shown in the fig – 2,3,4 (curve a). respectively. The uptake is found to be uniform upto 240V. form the thining experiments using 0.5μ . diamond paste the distribution curve isalso plotted and shown inth fig -2,3,4 (curve b) for zircaloy – 4 titanium and niobium respectively. From the nature

Table 1: Anodic films formed on Zircalo	y-2 in 0.1M	sodium metho	xide (SM)

Electrolyte	Formation rate, dv/dt	Current efficiency	Differential field,
	(V.Sec ⁻¹)	η(%)	FD(MV.cm ⁻¹)
0.1M SM	1.30	56.5	5.08
0.1M SM+0.001M PO ₄ -3	1.35	57.3	5.26

Table 2: Anodic films formed on Zircaloy-	-4 in 0.1M sodium methoxide (S	3M)
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Electrolyte	Formation rate, dv/dt	Current efficiency	Differential field,
	(V.Sec ⁻¹)	η(%)	FD(MV.cm ⁻¹)
0.1M SM	1.58	64.3	5.310
0.1M SM+0.001M PO ₄ -3	1.81	84.0	4.821

Table 3: Anodic films formed on Titasnium in 0.1M sodium methoxide (SM)

Electrolyte	Formation rate, dv/dt	Current efficiency	Differential field,
	(V.Sec ⁻¹)	η(%)	FD(MV.cm ⁻¹)
0.1M SM	1.20	39.0	7.12
0.1M SM+0.001M PO ₄ -3	1.45	64.5	3.36

Electrolyte	Formation rate, dv/dt	Current efficiency	Differential field,
	(V.Sec ⁻¹)	η(%)	FD(MV.cm ⁻¹)
0.1M SM	1.71	66.0	5.061
0.1M SM+0.001M PO ₄ -3	2.05	75	5.409

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of the uptake and distribution curves the mechanism of anodic film formation on Zircaloy – 4 titanium and niobium in 0.1M sodium methoxide+0.001M $Na_3^{32}PO_4$ is found tobe in the same order of uptake confirming the vacancy diffusion of metal ions. The same mechanism results were obtained by Shobha 16 for HF.

CONCLUSION

A marked influence and improvement in the kinetics of anodic oxide film formation on Zr-2,Zr-4, Ti and Nb in 0.1M sodium methoxide have been observed with the addition of 1mM of phosphate ions. Radio – tracer techniques confirmed the implantation and migration of phosphate ions in the oxide film the mechanism of the growth of the oxide film is found to be via interstitial movement of oxygen ions through out the film for Zircaloy - 2. for Zircaloy – 4. titanium and niobium the mechanism is found to be in the same order of uptake confirming the vacancy diffusion of metal ions.

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